

IGBT Module

SK35GD126ET

Preliminary Data

Features

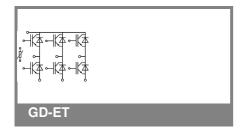
- Compact design
- · One screw mounting
- Heat transfer and isolation through direct copper bonded aluminium oxide ceramic (DCB)
- Ultrafast NPT technology IGBT
- CAL technology FWD
- Integrated NTC temperature sensor

Typical Applications*

Inverter

Absolute Maximum Ratings $T_s = 25 ^{\circ}\text{C}$, unless otherwise specified							
Symbol	Conditions			Values	Units		
IGBT							
V_{CES}	T _j = 25 °C			1200	V		
I _C	T _j = 150 °C	T _s = 25 °C		40	Α		
		$T_s = 80 ^{\circ}C$		32	Α		
I _{CRM}	I _{CRM} = 2 x I _{Cnom}			70	Α		
V_{GES}				± 20	V		
t _{psc}	V_{CC} = 600 V; $V_{GE} \le 20$ V; $V_{CES} < 1200$ V	T _j = 125 °C		10	μs		
Inverse Diode							
I_{F}	T _j = 150 °C	T_s = 25 °C		34	Α		
		$T_s = 80 ^{\circ}C$		23	Α		
I _{FRM}	I _{FRM} = 2 x I _{Fnom}			70	Α		
Module							
$I_{t(RMS)}$					Α		
T_{vj}				-40 + 150	°C		
T _{stg}				-40 + 125	°C		
V _{isol}	AC, 1 min.			2500	V		

Characteristics $T_s =$			25 °C, unless otherwise specified				
Symbol	Conditions		min.	typ.	max.	Units	
IGBT						•	
$V_{GE(th)}$	$V_{GE} = V_{CE}$, $I_C = 1.5 \text{ mA}$		5	5,8	6,5	V	
I _{CES}	V _{GE} = 0 V, V _{CE} = V _{CES}	T _j = 25 °C				mA	
		T _j = 125 °C				mA	
I _{GES}	V _{CE} = 0 V, V _{GE} = 20 V	T _j = 25 °C			600	nA	
		T _j = 125 °C				nA	
V _{CE0}		T _j = 25 °C		1	1,2	V	
		T _j = 125 °C		0,9		V	
r _{CE}	V _{GE} = 15 V	T _j = 25°C		20	26	mΩ	
		T _j = 125°C		31		mΩ	
V _{CE(sat)}	I _{Cnom} = 35 A, V _{GE} = 15 V	T _j = 25°C _{chiplev.}		1,7	2,1	V	
		$T_j = 125^{\circ}C_{chiplev.}$		2		V	
C _{ies}				2,5		nF	
C _{oes}	$V_{CE} = 25, V_{GE} = 0 V$	f = 1 MHz		0,132		nF	
C _{res}				0,115		nF	
$t_{d(on)}$				85		ns	
t _r	$R_{Gon} = 15 \Omega$	$V_{CC} = 600V$		30		ns	
E _{on}		I _C = 35A		4,6		mJ	
^t d(off)	$R_{Goff} = 15 \Omega$	T _j = 125 °C		430		ns	
t _f		V _{GE} =±15V		90		ns	
E _{off}				4,3		mJ	
$R_{th(j-s)}$	per IGBT				1,05	K/W	





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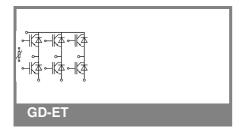
Typical Applications*

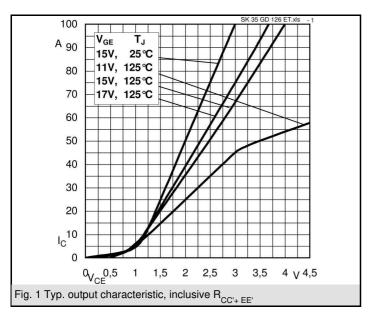
Inverter

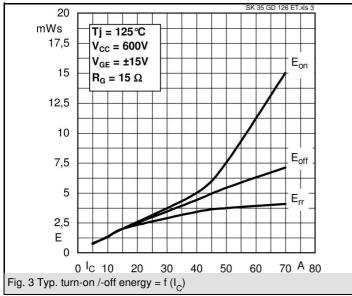
Characteristics							
Symbol	Conditions	ĺ	min.	typ.	max.	Units	
Inverse D	iode						
$V_F = V_{EC}$	I_{Fnom} = 35 A; V_{GE} = 0 V	$T_j = 25 ^{\circ}C_{chiplev.}$		1,8	2,1	V	
		$T_j = 125 ^{\circ}C_{\text{chiplev.}}$		1,8		V	
V_{F0}		T _j = 25 °C		1	1,1	V	
		T _j = 125 °C		0,8		V	
r _F		T _j = 25 °C		23	29	mΩ	
		T _j = 125 °C		31		mΩ	
I _{RRM}	I _F = 35 A	T _j = 125 °C		43		Α	
Q_{rr}	di/dt = -1330 A/µs			7		μC	
E _{rr}	V _{CC} = 600V			2,9		mJ	
$R_{th(j-s)D}$	per diode				1,7	K/W	
M _s	to heat sink		2,25		2,5	Nm	
w				30		g	
Temperature sensor							
R ₁₀₀	$T_s = 100^{\circ}C (R_{25} = 5k\Omega)$			493±5%		Ω	

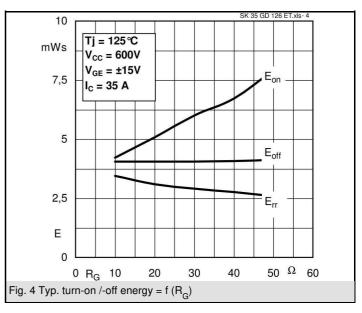
This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

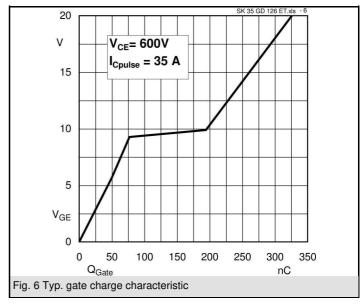
* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our personal.

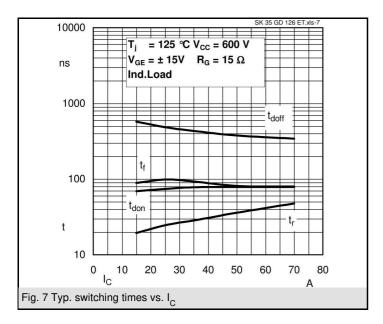


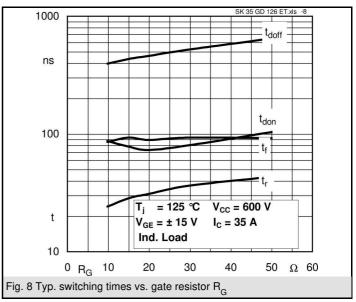


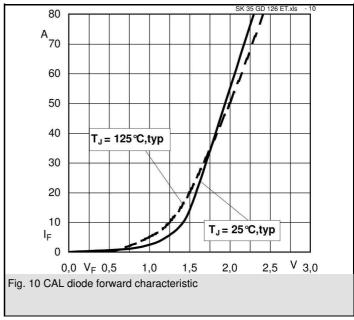




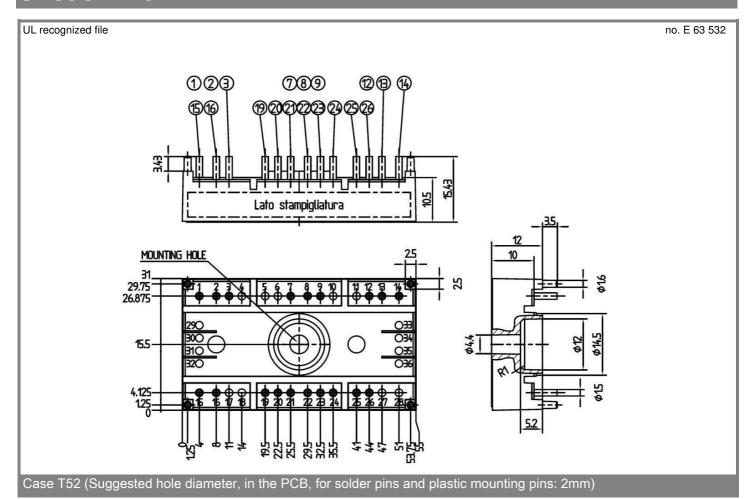


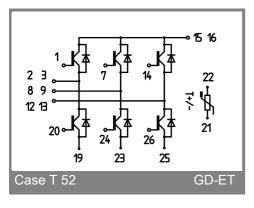






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